Usage Request Form – IITK Users

SEE Material Characterization – Stylus Profilometer

Sustainable Energy Engineering, IIT Kanpur

Date:

Name (PF/Roll No): Email/Phone No:					Supervisor's Name: Department:		
	Total no.		Sample	description		Total Charges (Rs.)	
S. No.	Sample Name/Code	Sample Type and Substrate Material	Approx thickness	Step Edge/ Scratch Mark Provided	Stability (Stable/Fragile)	Nature of Analysis: Film Thickness/ Step Height/ Surface Profiling and Roughness	
LAB	Date		Booking No			'	
USE	Done By		Log Page No		User's Signature		
Kindly	transfer Rs	(in w	vords) from Project	: No	
expirin	g on	, to	Account No. LD	A/IITK/SEE/2025	265.		
Head/PI/Supervisor				Fa	Facility Coordinator		

Sample Preparation Instructions

- Substrate Dimension: Provide solid samples, minimum 1 cm × 1 cm and maximum 10 cm × 10 cm.
- Marking: Kindly mark the side of the sample to be analyzed.
- Base Condition: Base of the sample must be flat for proper mounting on the sample holder.
- Dry Form: Samples must be in dry form.